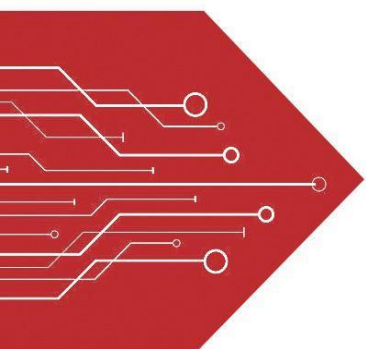


MSKSEMI

SEMICONDUCTOR



ESD



TVS



TSS



MOV



GDT

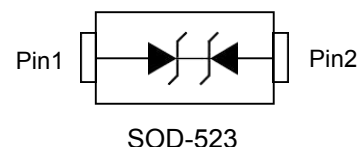


PLED

Product data sheet

Feature

80W peak pulse power per line ($t_p = 8/20\mu s$)
SOD-523 package
Replacement for MLV(0603)
Bidirectional configurations
Protects one power or I/O port
Low clamping voltage
RoHS compliant
Transient protection for data lines to IEC 61000-4-2(ESD)
 $\pm 30kV$ (air), $\pm 30kV$ (contact); IEC 61000-4-4 (EFT) 40A (5/50ns)



Applications

Cellular phones
Portable devices
Digital cameras
Power supplies

Mechanical Characteristics

Lead finish:100% matte Sn(Tin)
Mounting position: Any
Qualified max reflow temperature:260°C
Device meets MSL 1 requirements
Pure tin plating: 7 ~ 17 μm
Pin flatness: $\leq 3mil$

Electrical characteristics per line@25?(unless otherwisespecified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Peak Reverse Working Voltage	V_{RWM}			3.3		V
Breakdown Voltage	V_{BR}	$I_T = 1mA$	4.8		6.8	V
Reverse Leakage Current	I_R	$V_{RWM} = 5V$ $T=25^\circ C$			1.0	μA
Clamping Voltage ¹⁾	V_C	$TLP = 16A$, $t_p = 100ns$		9.0		V
Dynamic resistance ¹⁾	R_{DYN}			0.15		Ω
Clamping Voltage ²⁾	V_C	$I_{PP}=10A$		8	10	V
Junction Capacitance	C_J	$V_R=0V$ $f = 1MHz$		33		pF

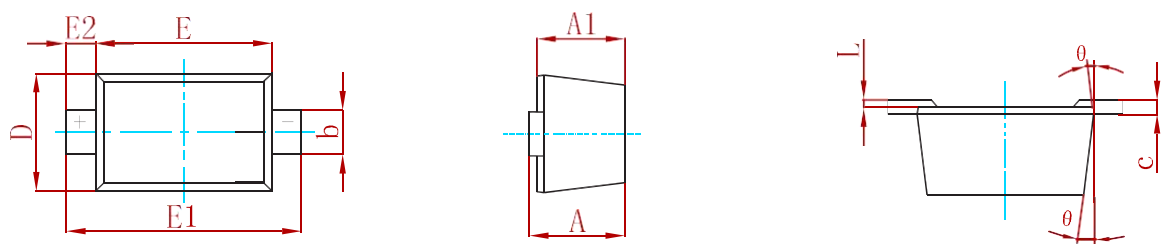
Notes:

- 1.TLP parameter: $Z_0=50\Omega$, $t_p=100ns$, $t_r=2ns$, averaging window from 60ns to 80ns. R_{DYN} is calculated from 4A to 16A.
- 2.Non-repetitive current pulse, according to IEC61000-4-5.

Absolute maximum rating@25?

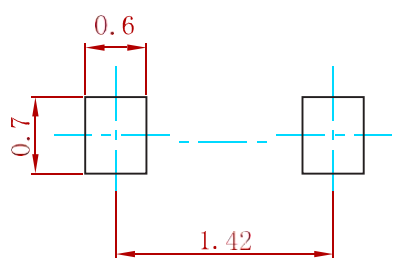
Rating	Symbol	Value	Unit
Peak Pulse Power ($t_p=8/20\mu s$)	P_{pp}	80	W
Operating Temperature	T_J	-55 to +150	$^\circ C$
Storage Temperature	T_{STG}	-55 to +150	$^\circ C$

PACKAGE MECHANICAL DATA



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	0.510	0.770	0.020	0.031
A1	0.500	0.700	0.020	0.028
b	0.250	0.350	0.010	0.014
c	0.080	0.150	0.003	0.006
D	0.750	0.850	0.030	0.033
E	1.100	1.300	0.043	0.051
E1	1.500	1.700	0.059	0.067
E2	0.200 REF		0.008 REF	
L	0.010	0.070	0.001	0.003
θ	7° REF		7° REF	

Suggested Pad Layout



- Note:
- 1.Controlling dimension:in millimeters.
 - 2.General tolerance:± 0.05mm.
 - 3.The pad layout is for reference purposes only.

REEL SPECIFICATION

P/N	PKG	QTY
AZ5123-01H-MS	SOD-523	3000

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